

General Description:

The LWT1H6AM uses SGT technology and design to provide excellent $R_{DS(ON)}$ with low gate charge. It can be used in a wide variety of applications. The package form is SOT23, which accords with the ROHS standard and Halogen Free standard.

Features:

- Fast Switching
- Low Gate Charge and $R_{DS(ON)}$
- Low Reverse transfer capacitances

Applications:

- DC-DC Converter
- Portable Equipment
- Power Management



Package Marking and Ordering Information:

| Marking | Part Number | Package | Packing | Qty. |
|---------|-------------|---------|---------|----------|
| T1H6A | LWT1H6AM | SOT23 | Reel | 3000 Pcs |

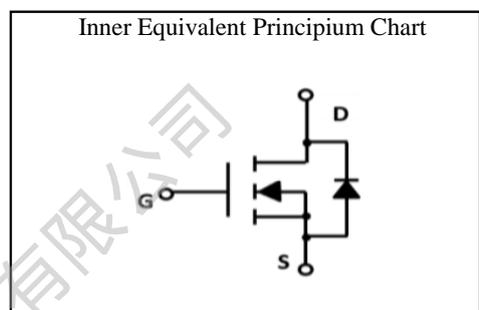
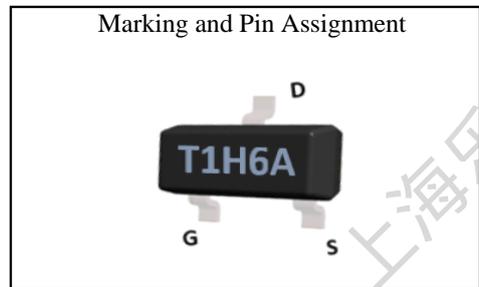
Absolute Maximum Ratings:

| Symbol | Parameter | Value | Units |
|----------------|--|-------------------------|------------------|
| V_{DSS} | Drain-to-Source Voltage | 100 | V |
| I_D | Continuous Drain Current | $T_C=25^\circ\text{C}$ | 4.0 |
| | Continuous Drain Current | $T_C=100^\circ\text{C}$ | 2.5 |
| I_{DM}^{al} | Pulsed Drain Current | 12 | A |
| V_{GS} | Gate-to-Source Voltage | ± 20 | V |
| P_D | Power Dissipation | 2.0 | W |
| T_J, T_{STG} | Operating Junction and Storage Temperature Range | 150, -55 to 150 | $^\circ\text{C}$ |
| T_L | Maximum Temperature for Soldering | 260 | $^\circ\text{C}$ |

Thermal Characteristics:

| Symbol | Parameter | Value | Units |
|-----------------|---|-------|---------------------------|
| $R_{\theta JA}$ | Thermal Resistance, Junction-to-Ambient | 62.5 | $^\circ\text{C}/\text{W}$ |

| | | |
|---------------------------|-----|------------------|
| V_{DSS} | 100 | V |
| I_D | 4.0 | A |
| P_D | 2.0 | W |
| $R_{DS(ON) \text{ TYPE}}$ | 100 | $\text{m}\Omega$ |



Electrical Characteristic ($T_A = 25\text{ }^\circ\text{C}$, unless otherwise specified):

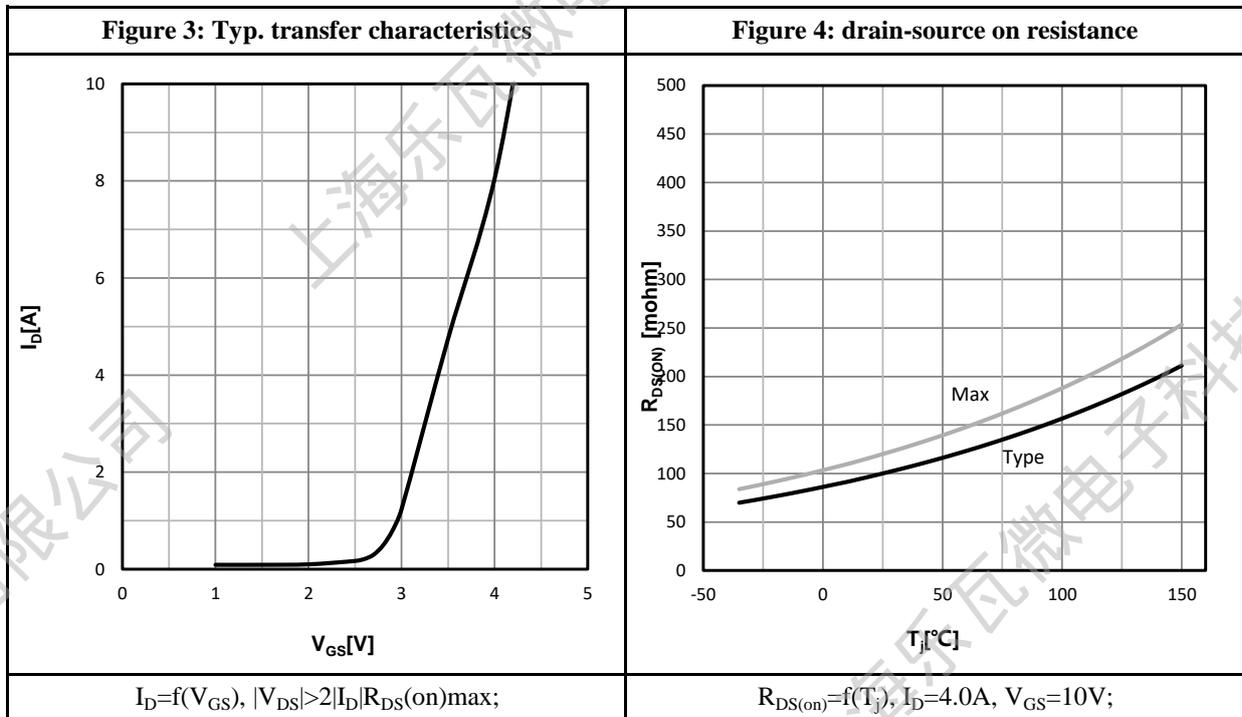
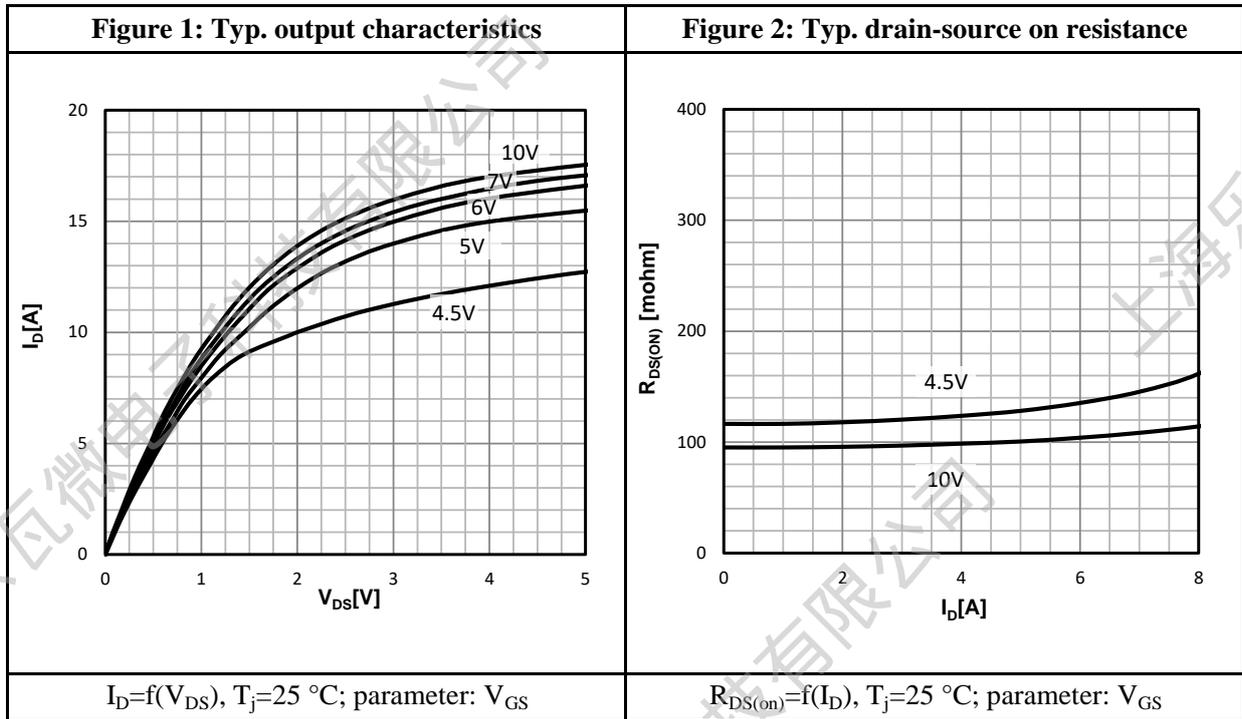
| Static Characteristics | | | | | | |
|------------------------|-----------------------------------|-------------------------------|-------|------|------|------------|
| Symbol | Parameter | Test Conditions | Value | | | Units |
| | | | Min. | Typ. | Max. | |
| V_{DSS} | Drain to Source Breakdown Voltage | $V_{GS}=0V, I_D=250\mu A$ | 100 | -- | -- | V |
| I_{DSS} | Drain to Source Leakage Current | $V_{DS}=100V, V_{GS}=0V$ | -- | -- | 1.0 | μA |
| $I_{GSS(F)}$ | Gate to Source Forward Leakage | $V_{GS}=+20V, V_{DS}=0V$ | -- | -- | 100 | nA |
| $I_{GSS(R)}$ | Gate to Source Reverse Leakage | $V_{GS}=-20V, V_{DS}=0V$ | -- | -- | -100 | nA |
| $V_{GS(TH)}$ | Gate Threshold Voltage | $V_{DS}=V_{GS}, I_D=250\mu A$ | 1.3 | 1.8 | 2.4 | V |
| $R_{DS(ON)1}$ | Drain-to-Source On-Resistance | $V_{GS}=10V, I_D=4.0A$ | -- | 100 | 120 | m Ω |
| $R_{DS(ON)2}$ | Drain-to-Source On-Resistance | $V_{GS}=4.5V, I_D=3.0A$ | -- | 120 | 145 | m Ω |

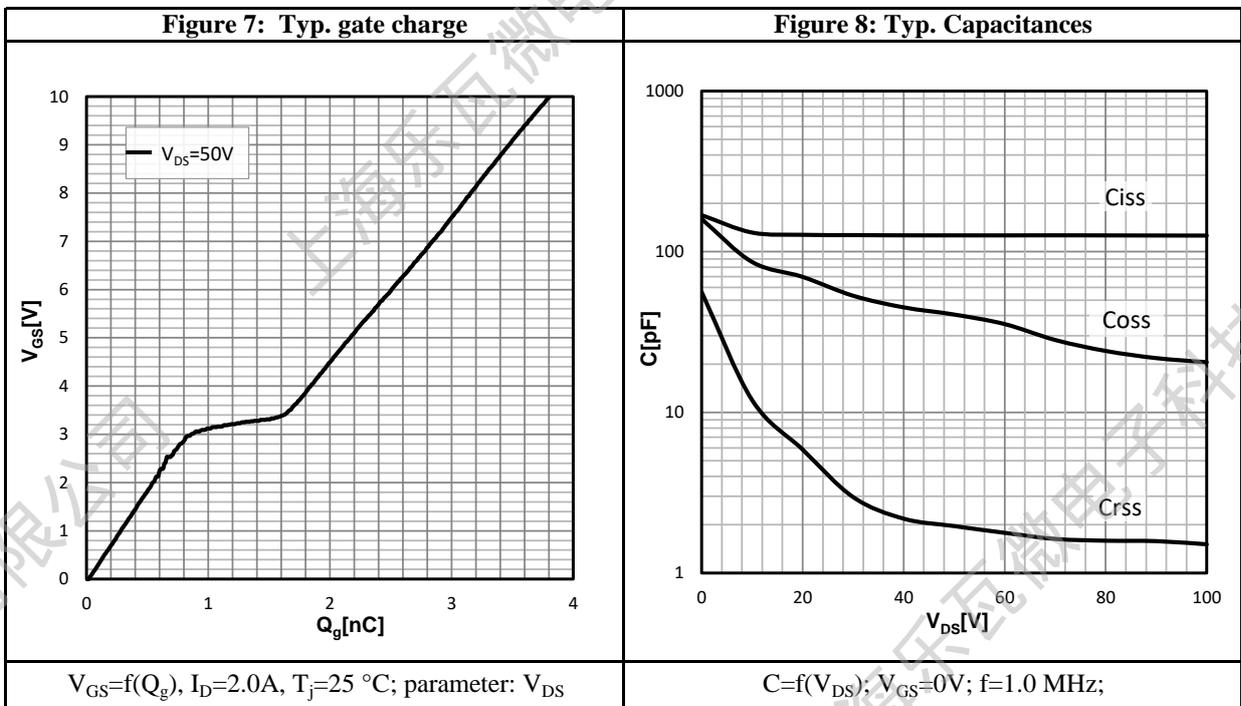
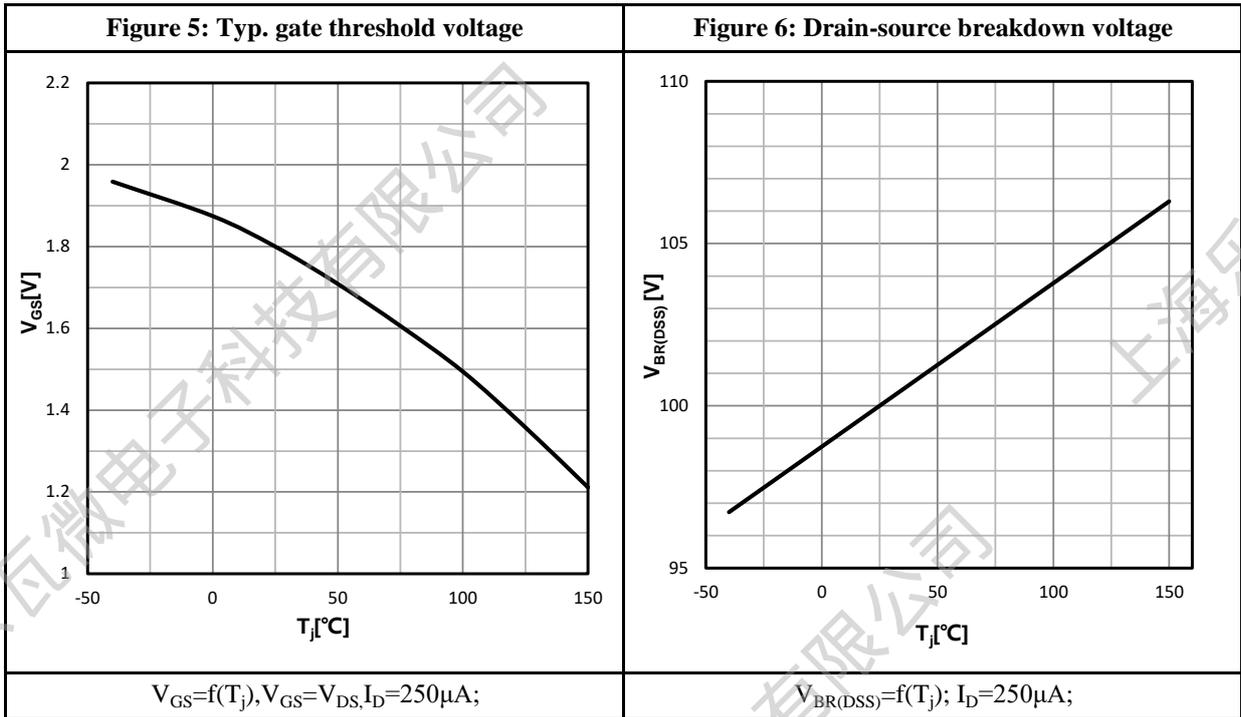
| Dynamic Characteristics | | | | | | |
|-------------------------|------------------------------|--------------------------|-------|------|------|----------|
| Symbol | Parameter | Test Conditions | Value | | | Units |
| | | | Min. | Typ. | Max. | |
| C_{iss} | Input Capacitance | $V_{GS} = 0V$ | -- | 126 | -- | pF |
| C_{oss} | Output Capacitance | $V_{DS} = 50V$ | -- | 40.6 | -- | |
| C_{rss} | Reverse Transfer Capacitance | $f = 1.0MHz$ | -- | 1.96 | -- | |
| R_G | Gate resistance | $V_{GS}=0V, V_{DS}$ Open | -- | 5.8 | -- | Ω |

| Resistive Switching Characteristics | | | | | | |
|-------------------------------------|---------------------|-------------------|-------|------|------|-------|
| Symbol | Parameter | Test Conditions | Value | | | Units |
| | | | Min. | Typ. | Max. | |
| $t_{d(ON)}$ | Turn-on Delay Time | $I_D = 2.0A$ | -- | 4.5 | -- | ns |
| t_r | Rise Time | $V_{DS} = 50V$ | -- | 1.5 | -- | |
| $t_{d(OFF)}$ | Turn-Off Delay Time | $V_{GS} = 10V$ | -- | 8.0 | -- | |
| t_f | Fall Time | $R_G = 5.0\Omega$ | -- | 3.4 | -- | |
| Q_g | Total Gate Charge | $V_{GS} = 10V$ | -- | 3.81 | -- | nC |
| Q_{gs} | Gate Source Charge | $V_{DS} = 50V$ | -- | 0.52 | -- | |
| Q_{gd} | Gate Drain Charge | $I_D = 2.0A$ | -- | 0.71 | -- | |

| Source-Drain Diode Characteristics | | | | | | |
|------------------------------------|-----------------------|----------------------------------|-------|------|------|-------|
| Symbol | Parameter | Test Conditions | Value | | | Units |
| | | | Min. | Typ. | Max. | |
| I_S | Diode Forward Current | $T_C = 25\text{ }^\circ\text{C}$ | -- | -- | 4.0 | A |
| V_{SD} | Diode Forward Voltage | $I_S=2.0A, V_{GS}=0V$ | -- | -- | 1.2 | V |

a1: Repetitive rating; pulse width limited by maximum junction temperature

Characteristics Curve:




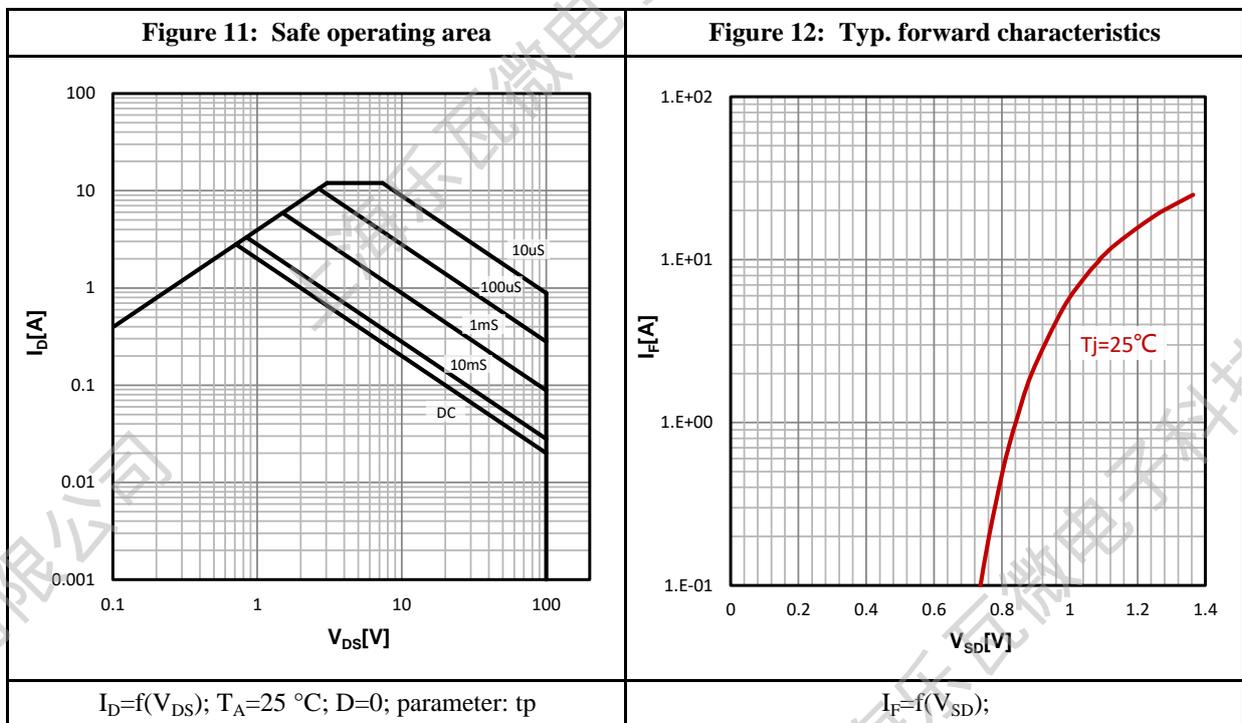
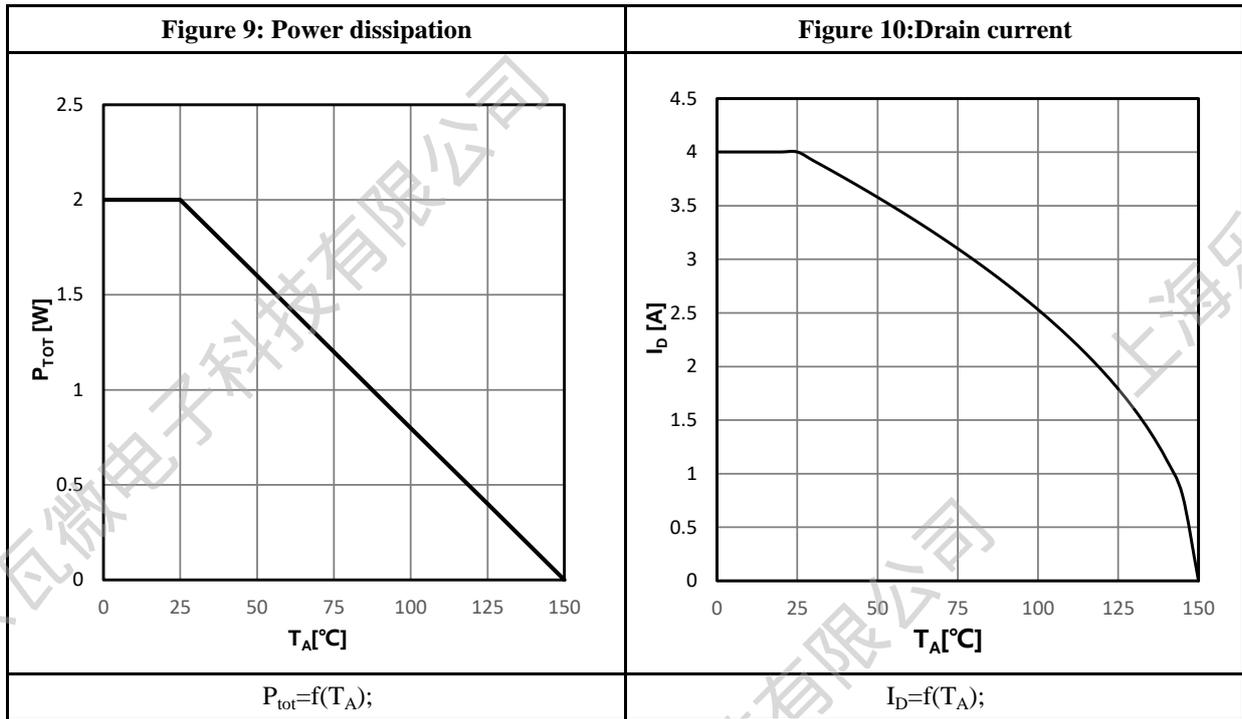
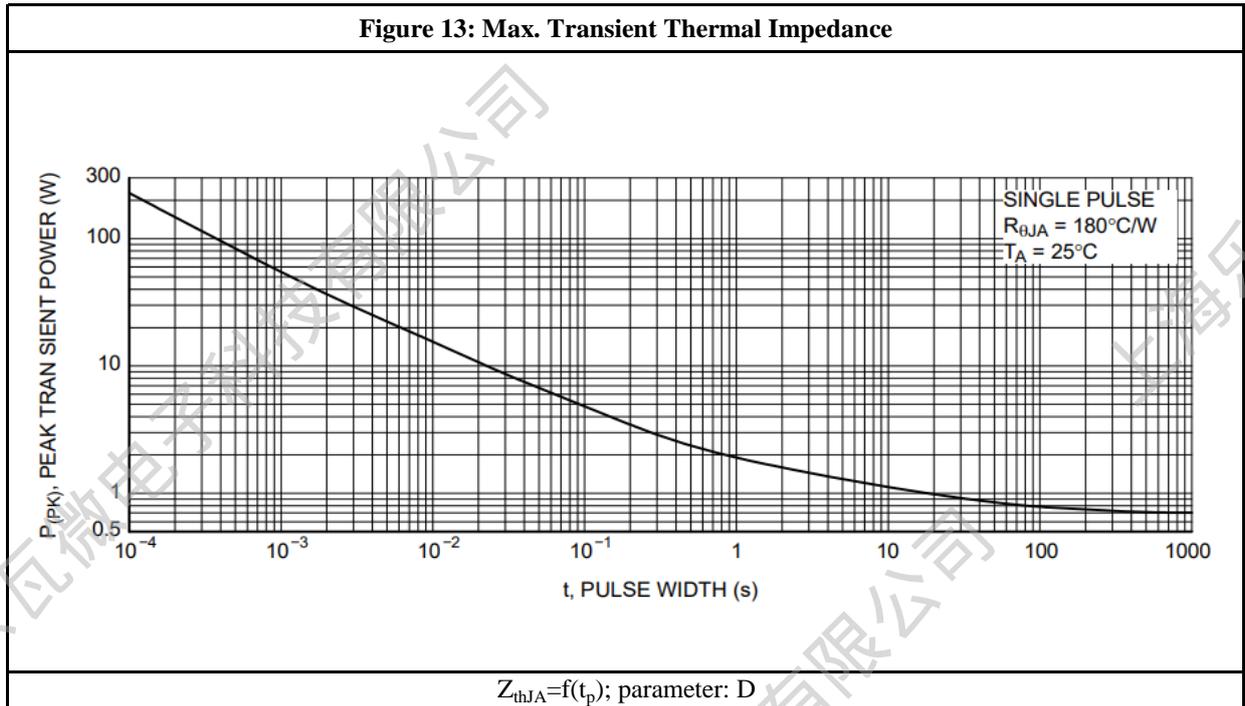
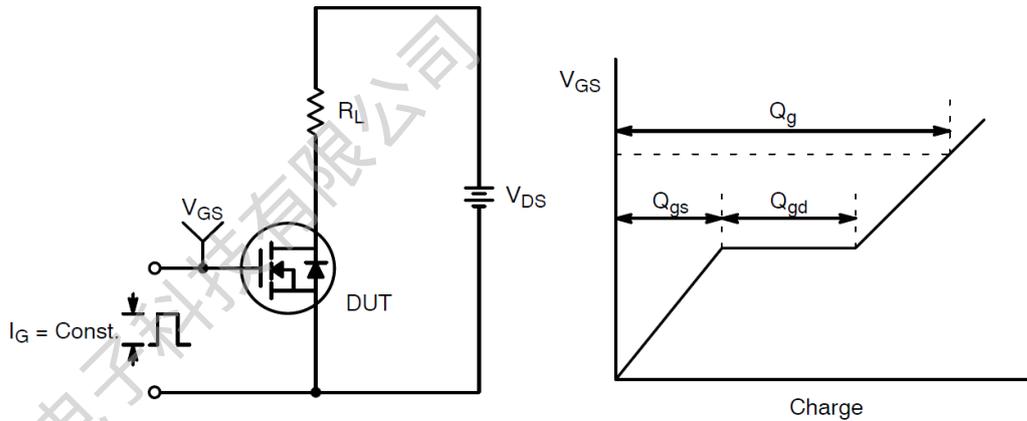
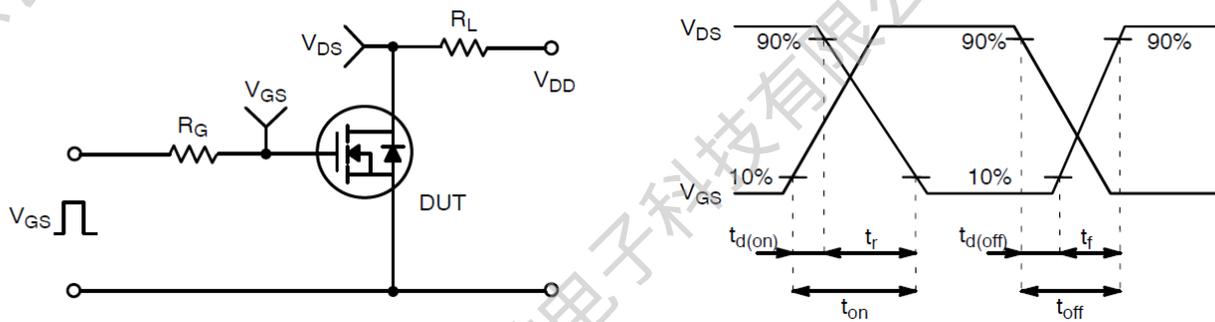
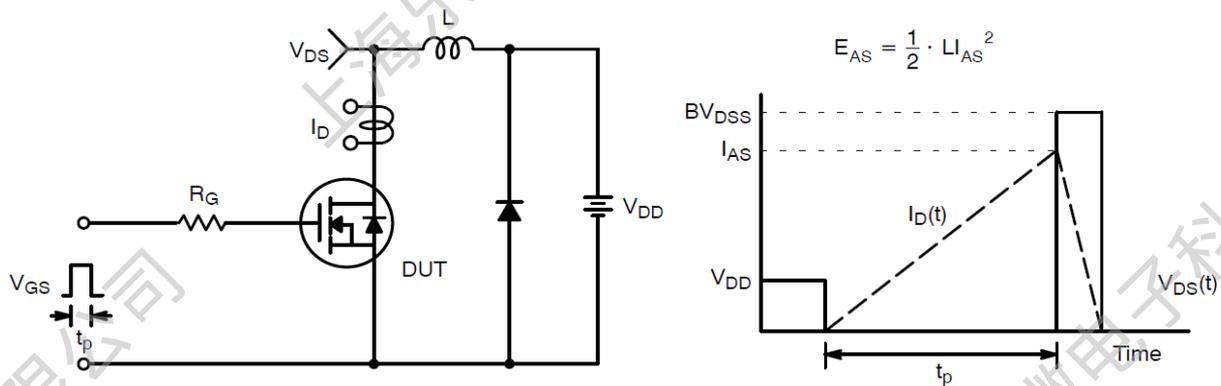
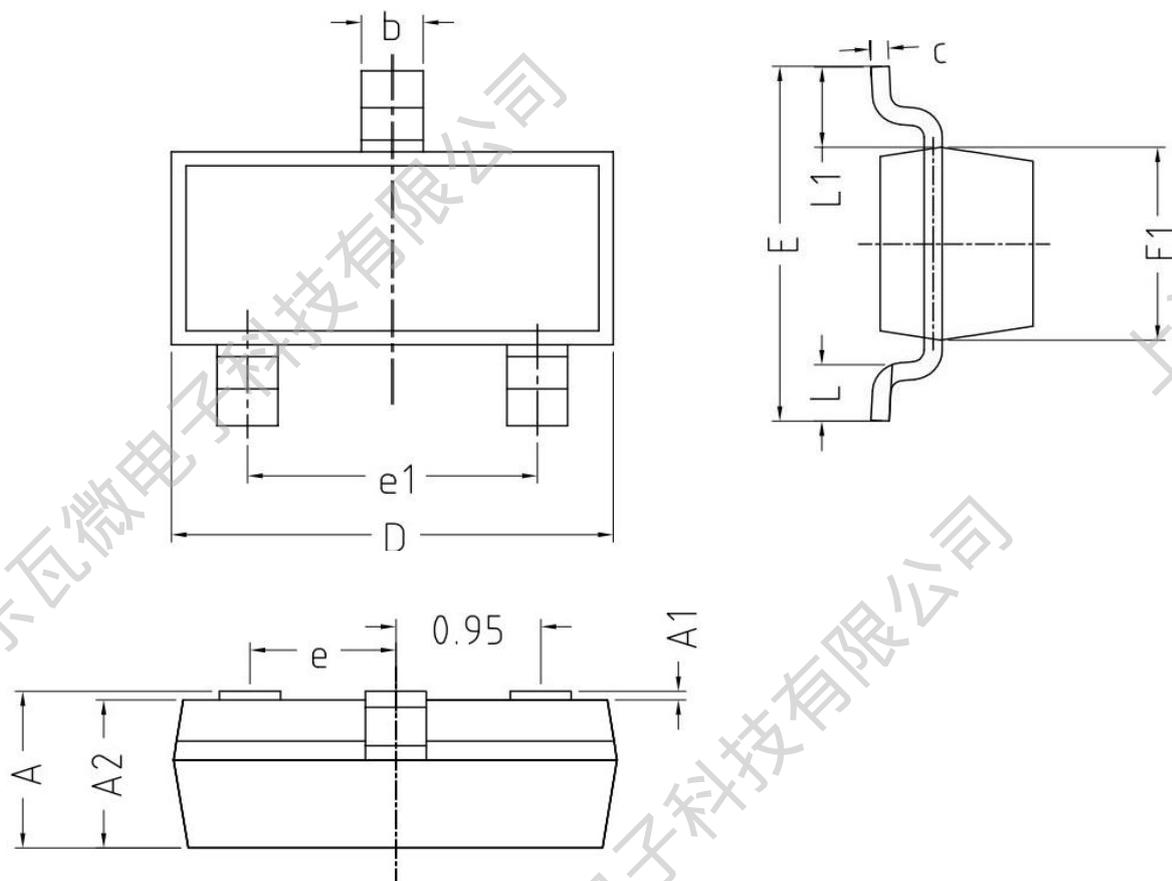


Figure 13: Max. Transient Thermal Impedance



Test Circuit & Waveform:

Figure 14: Gate Charge Test Circuit & Waveform

Figure 15: Resistive Switching Test Circuit & Waveforms

Figure 16: Unclamped Inductive Switching Test Circuit & Waveforms

Package Outline:


| COMMON IN DIMENSION (MM) | | | |
|--------------------------|-----------|-------|-------|
| Symbol | Min. | Nom. | Max. |
| A | 0.900 | 1.050 | 1.150 |
| A1 | 0.000 | 0.050 | 0.100 |
| A2 | 0.900 | 1.000 | 1.050 |
| b | 0.300 | 0.400 | 0.500 |
| C | 0.100 | 0.130 | 0.200 |
| D | 2.800 | 2.900 | 3.000 |
| E | 2.250 | 2.400 | 2.550 |
| E1 | 1.200 | 1.300 | 1.400 |
| e | 0.950 TYP | | |
| e1 | 1.800 | 1.900 | 2.000 |
| L | 0.290 | 0.390 | 0.490 |
| L1 | 0.550REF | | |

Revision History:

| Revison | Date | Descriptions |
|----------------|-------------|---------------------|
| Rev 1.0 | Feb.2024 | Initial Version |

Disclaimer:

The information in this document is believed to be accurate and reliable. However, no responsibility is assumed by LW-Micro for its use. All operating parameters must be designed, validated and tested to ensure they meet the requirements of your application. LW-Micro reserves the right to make any specification and/or circuitry changes without prior notification. Before starting a brand-new project, please contact LW-Micro Sales to get the most recent relevant information.

Mailing Address: Room 301, Building 2, No.1690 CaiLun Road, China (Shanghai) Pilot Free Trade Zone
Shanghai Lewa Micro-electronics Technology Co., Ltd